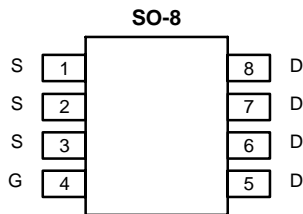
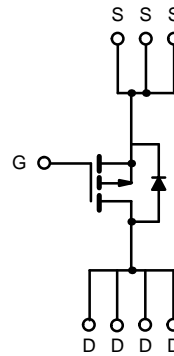


P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY		
V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
-30	0.019 @ $V_{GS} = -10$ V	-8.0
	0.033 @ $V_{GS} = -4.5$ V	-6.0



Ordering Information: Si4835DY
Si4835DY-T1 (with Tape and Reel)



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)				
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	-30	V
Gate-Source Voltage		V_{GS}	± 25	
Continuous Drain Current ($T_J = 150^\circ\text{C}$) ^{a, b}	$T_A = 25^\circ\text{C}$	I_D	-8.0	A
	$T_A = 70^\circ\text{C}$		-6.4	
Pulsed Drain Current		I_{DM}	-50	
Continuous Source Current (Diode Conduction) ^{a, b}		I_S	-2.1	
Maximum Power Dissipation ^{a, b}	$T_A = 25^\circ\text{C}$	P_D	2.5	W
	$T_A = 70^\circ\text{C}$		1.6	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^a	$t \leq 10$ sec	R_{thJA}		50	$^\circ\text{C/W}$
	Steady State		70		

Notes
a. Surface Mounted on FR4 Board.
b. $t \leq 10$ sec.

SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

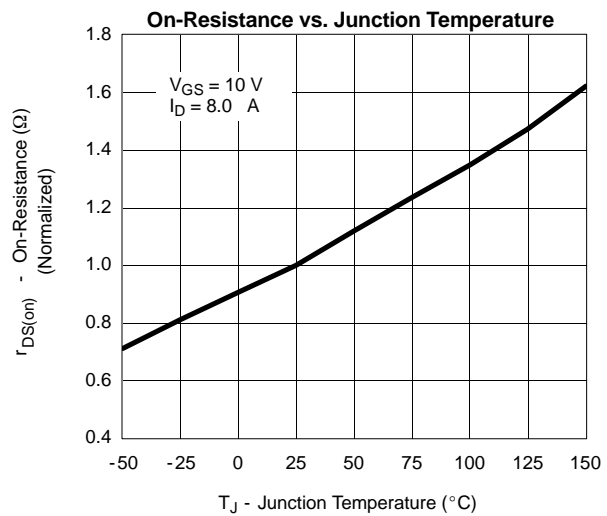
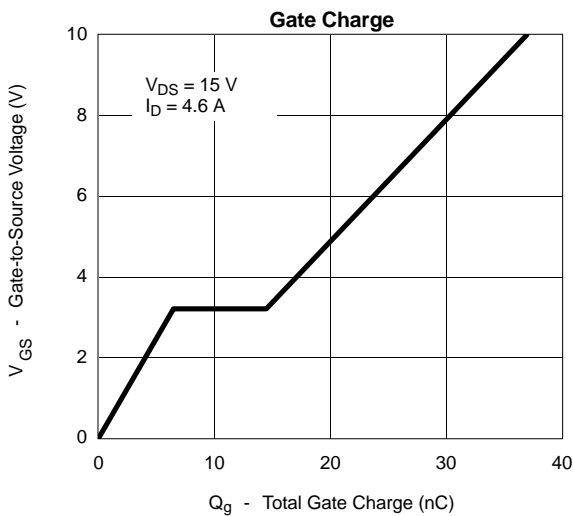
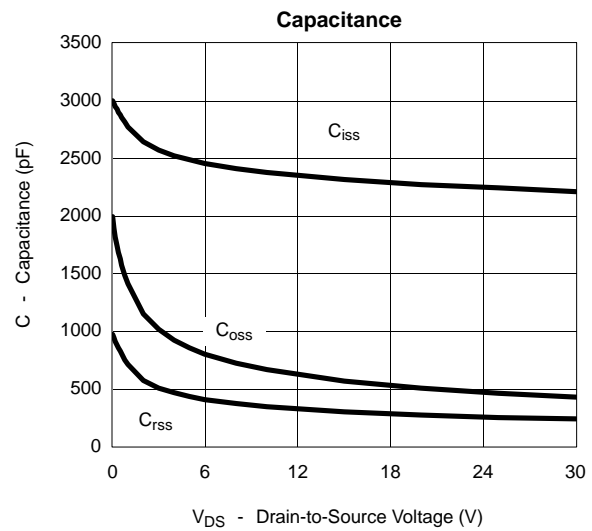
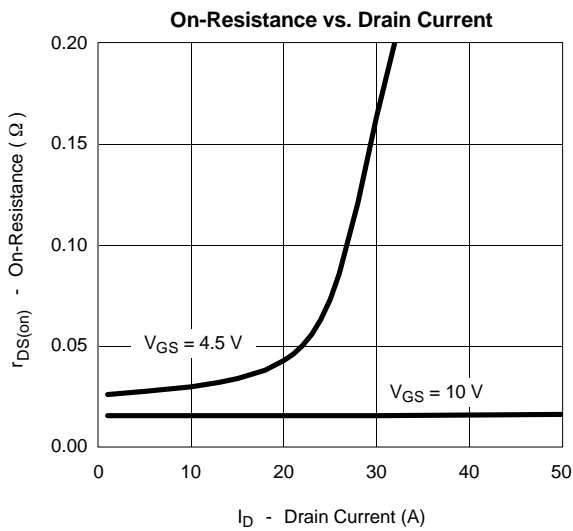
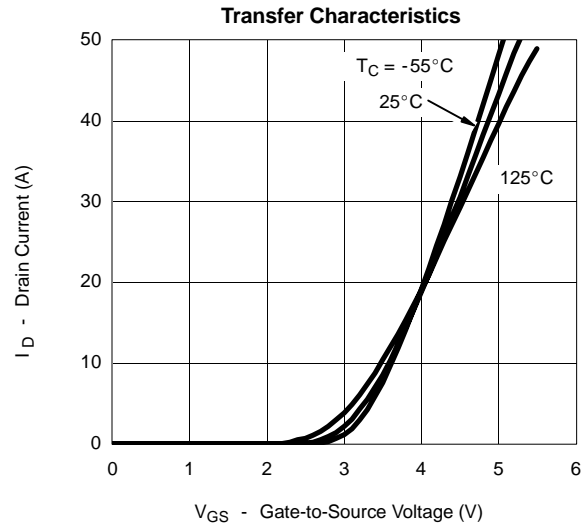
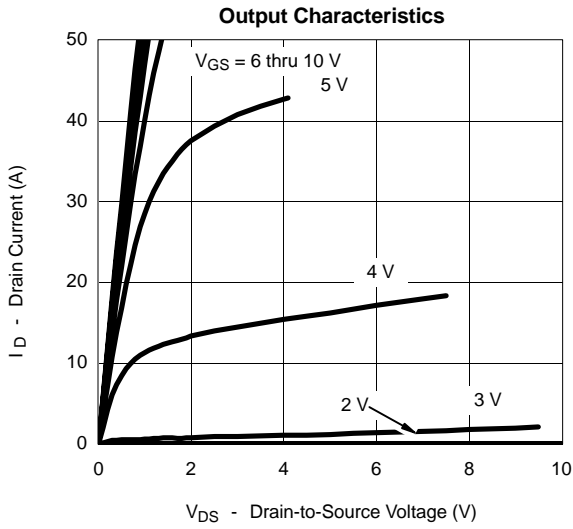
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	-1.0			V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\ \text{V}, V_{GS} = \pm 25\ \text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -30\ \text{V}, V_{GS} = 0\ \text{V}$			-1	μA
		$V_{DS} = -30\ \text{V}, V_{GS} = 0\ \text{V}, T_J = 70^\circ\text{C}$			-5	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \geq -5\ \text{V}, V_{GS} = -10\ \text{V}$	-40			A
		$V_{DS} \geq -5\ \text{V}, V_{GS} = -4.5\ \text{V}$	-10			
Drain-Source On-State Resistance ^a	$r_{DS(on)}$	$V_{GS} = -10\ \text{V}, I_D = -8.0\ \text{A}$		0.0155	0.019	Ω
		$V_{GS} = -4.5\ \text{V}, I_D = -5.0\ \text{A}$		0.027	0.033	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -15\ \text{V}, I_D = -8.0\ \text{A}$		17		S
Diode Forward Voltage ^a	V_{SD}	$I_S = -2.1\ \text{A}, V_{GS} = 0\ \text{V}$		-0.75	-1.2	V
Dynamic^b						
Total Gate Charge	Q_g	$V_{DS} = -10\ \text{V}, V_{GS} = -5\ \text{V}, I_D = -4.6\ \text{A}$		21	31	nC
Gate-Source Charge	Q_{gs}			6.5		
Gate-Drain Charge	Q_{gd}			8		
Gate Resistance	R_g		1.0	2.6	4.4	Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -15\ \text{V}, R_L = 15\ \Omega$ $I_D \cong -1\ \text{A}, V_{GEN} = -10\ \text{V}, R_G = 6\ \Omega$		16	30	ns
Rise Time	t_r			13	25	
Turn-Off Delay Time	$t_{d(off)}$			56	100	
Fall Time	t_f			30	60	
Source-Drain Reverse Recovery Time	t_{rr}	$I_F = -2.1\ \text{A}, di/dt = 100\ \text{A}/\mu\text{s}$		40	80	

Notes

- a. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.
b. Guaranteed by design, not subject to production testing.



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

